

EE40 Summer 2006: Lecture 17

Instructor: Octavian Florescu

2





Integrated Circuit Fabrication Goal:

Mass fabrication (*i.e.* simultaneous fabrication) of many "chips", each a circuit (e.g. a microprocessor or memory chip) containing millions or billions of transistors

Method:

Lay down thin films of semiconductors, metals and insulators and pattern each layer with a process much like printing (lithography).

Materials used in a basic CMOS integrated circuit:

- Si substrate selectively doped in various regions
- SiO₂ insulator
- Polycrystalline silicon used for the gate electrodes
- Metal contacts and wiring

<image><image><image><image><image><image><image>

Crystals are grown from a melt in boules (cylinders) with

perfectly round and oriented (a "flat" or "notch" is ground along the boule) and then sliced like baloney into wafers.

specified dopant concentrations. They are ground

Adding Dopants into Si

Si Substrates (Wafers)

Suppose we have a wafer of Si which is p-type and we want to change the surface to n-type. The way in which this is done is by *ion implantation*. Dopant ions are shot out of an "ion gun" called an *ion implanter,* into the surface of the wafer.

Eaton HE3 High-Energy Implanter, showing the ion beam _____ hitting the end-station





Typical implant energies are in the range 1-200 keV. After the ion implantation, the wafers are heated to a high temperature (~1000°C). This "annealing" step heals the damage and causes the implanted **dopant atoms to move into substitutional lattice sites**.



Formation of Insulating Films

- The favored insulator is pure silicon dioxide (SiO₂).
- A SiO₂ film can be formed by one of two methods:
 - 1. Oxidation of Si at high temperature in O₂ or steam ambient
 - 2. Deposition of a silicon dioxide film

ASM A412 batch oxidation furnace



Applied Materials lowpressure chemical-vapor deposition (CVD) chamber



EE40 Summer 2006: Lecture 17



12



EE40 Summer 2006: Lecture 17

Instructor: Octavian Florescu





Properties:

- sheet resistance (heavily doped, 0.5 μ m thick) = 20 Ω/\Box
- can withstand high-temperature anneals → major advantage











Pattern Transfer by Etching

In order to transfer the photoresist pattern to an underlying film, we need a "subtractive" process that removes the film, ideally with minimal change in the pattern and with minimal removal of the underlying material(s)

\rightarrow <u>Selective</u> etch processes (using plasma or aqueous chemistry) have been developed for most IC materials





Lithography Trends

 Lithography determines the minimum feature size and limits the throughput that can be achieved in an IC manufacturing process. Thus, lithography research & development efforts are directed at

1. achieving higher resolution

→ shorter wavelengths 365 nm → 248 nm → 193 nm → 13 nm "i-line" "DUV" "EUV"

2. improving resist materials

 → higher sensitivity, for shorter exposure times (throughput target is 60 wafers/hr)



Micromachining to make MEMS devices



An example of a micromachined part – the world's smallest guitar. The strings are only 5 nm wide and they actually can be made to vibrate when touched (carefully) with a fine probe. Guitar made by **SURFACE MICROMACHING** (below).



Rapid Thermal Annealing (RTA)

Sub-micron MOSFETs need ultra-shallow junctions ($x_i < 50$ nm)

- ightarrow Dopant diffusion during "activation" anneal must be minimized
 - \rightarrow Short annealing time (<1 min.) at high temperature is required
- Ordinary furnaces (e.g. used for thermal oxidation and CVD) heat and cool wafers at a slow rate (<50°C per minute)
- Special annealing tools have been developed to enable much faster temperature ramping, and precise control of annealing time
 - ramp rates as fast as 200°C/second
 - anneal times as short as 0.5 second
 - typically single-wafer process chamber:



Chemical Mechanical Polishing (CMP)

Chemical mechanical polishing is used to planarize the surface of a wafer at various steps in the process of fabricating an integrated circuit.





EE40 Summer 2006: Lecture 17

